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INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Yoshiro SHIOKAWA et al.			
				FILING DATE December 21, 2001		GROUP JC503 U.S. PTO 10/24/243 12/10/11	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUB CLASS
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUB CLASS
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
<i>PT</i>	<i>✓</i>	R. V. Hodges et al., "Application of Alkali Ions in Chemical Ionization Mass Spectrometry", <u>Analytic Chemistry</u> , Vol. 48, No. 6, pp. 825-829, (1976).					
<i>PT</i>	<i>✓</i>	D. Bombick et al., "Potassium Ion Chemical Ionization and Other Uses of an Alkali Thermionic Emitter in Mass Spectrometry", <u>Analytic Chemistry</u> , Vol. 56, No. 3, pp. 396-402, (1984).					
<i>PT</i>	<i>✓</i>	Toshihiro Fujii et al., "Chemical Ionization Mass Spectrometry with Lithium Ion Attachment to the Molecule", <u>Analytical Chemistry</u> , Vol. 61, No. 9, pp. 1026-1029, (1989).					
<i>PT</i>	<i>✓</i>	Toshihiro Fujii, "A Novel Method for Detection of Radical Species in the Gas Phase: Usage of Li ⁺ Ion Attachment to Chemical Species", <u>Chemical Physics Letters</u> , Vol. 191, No. 1, pp. 162-168, (1992).					
<i>PT</i>	<i>✓</i>	Japanese Patent Abstracts of JP-A-06-011485.					
EXAMINER <i>Deepti Shukla</i>		DATE CONSIDERED <i>5-30-03</i>					
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							